

<b>Notice of References Cited</b>	Application/Control No. 10/620,620	Applicant(s)/Patent Under Reexamination KIM, HYEONG SEO	
	Examiner Tu X. Nguyen	Art Unit 2618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,192,230 B1	02-2001	van Bokhorst et al.	455/343.3
	B	US-2002/0132603 A1	09-2002	Lindskog et al.	455/343
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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